

Notice of References Cited	Application/Control No. 10/616,703		Applicant(s)/Patent Under Reexamination OLIVER ET AL.	
	Examiner Oanh Duong		Art Unit 2155	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0105827 A1	06-2003	Tan et al.	709/206
*	B	US-7,206,814	04-2007	Kirsch, Steven T.	709/206
*	C	US-7,006,993 B1	02-2006	Cheong et al.	705/38
*	D	US-7,231,428 B2	06-2007	Teague, Alan H.	709/206
*	E	US-2001/0044803 A1	11-2001	Szutu, Kehyeh	707/104.1
*	F	US-2001/0047391 A1	11-2001	Szutu, Kehyeh	709/206
*	G	US-2002/0087573 A1	07-2002	Reuning et al.	707/102
*	H	US-7,293,063 B1	11-2007	Sobel, William E	709/206
*	I	US-6,963,928 B1	11-2005	Bagley et al.	709/245
*	J	US-7,178,099 B2	02-2007	Meyer et al.	715/513
*	K	US-2003/0041126	02-2003	Buford et al.	709/220
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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